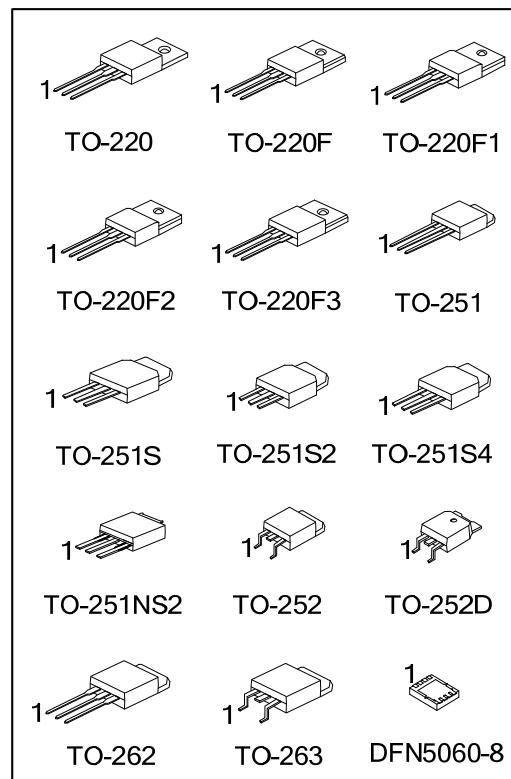
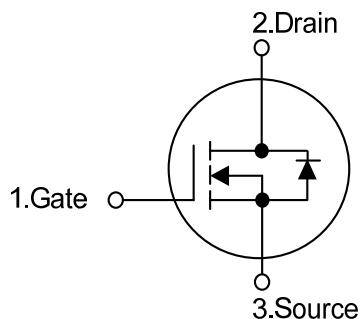


4N65-E***Power MOSFET*****4A, 650V N-CHANNEL
POWER MOSFET****■ DESCRIPTION**

The UTC **4N65-E** is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristic. This power MOSFET is usually used in high speed switching applications including power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

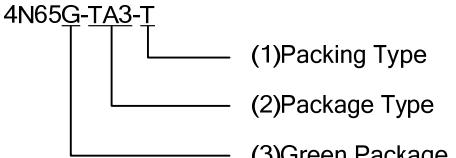
- * $R_{DS(ON)} < 2.5\Omega$ @ $V_{GS} = 10$ V, $I_D = 2.2$ A
- * Fast Switching Capability
- * Avalanche Energy Specified
- * Improved dv/dt Capability, High Ruggedness

■ SYMBOL

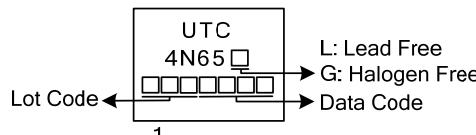
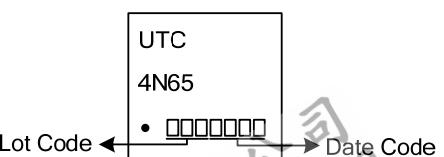
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
4N65L-TA3-T	4N65G-TA3-T	TO-220	G	D	S	-	-	-	-	-	Tube
4N65L-TF1-T	4N65G-TF1-T	TO-220F1	G	D	S	-	-	-	-	-	Tube
4N65L-TF2-T	4N65G-TF2-T	TO-220F2	G	D	S	-	-	-	-	-	Tube
4N65L-TF3-T	4N65G-TF3-T	TO-220F	G	D	S	-	-	-	-	-	Tube
4N65L-TF3T-T	4N65G-TF3T-T	TO-220F3	G	D	S	-	-	-	-	-	Tube
4N65L-TM3-T	4N65G-TM3-T	TO-251	G	D	S	-	-	-	-	-	Tube
4N65L-TMS-T	4N65G-TMS-T	TO-251S	G	D	S	-	-	-	-	-	Tube
4N65L-TMS2-T	4N65G-TMS2-T	TO-251S2	G	D	S	-	-	-	-	-	Tube
4N65L-TMS4-T	4N65G-TMS4-T	TO-251S4	G	D	S	-	-	-	-	-	Tube
4N65L-TMN2-T	4N65G-TMN2-T	TO-251NS2	G	D	S	-	-	-	-	-	Tube
4N65L-TN3-R	4N65G-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
4N65L-TND-R	4N65G-TND-R	TO-252D	G	D	S	-	-	-	-	-	Tape Reel
4N65L-T2Q-T	4N65G-T2Q-T	TO-262	G	D	S	-	-	-	-	-	Tube
4N65L-TQ2-R	4N65G-TQ2-R	TO-263	G	D	S	-	-	-	-	-	Tape Reel
4N65L-TQ2-T	4N65G-TQ2-T	TO-263	G	D	S	-	-	-	-	-	Tube
4N65G-K08-5060-R	4N65G-K08-5060-R	DFN5060-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TF1: TO-220F1, TF2: TO-220F2 TF3: TO-220F, TF3T: TO-220F3, TM3: TO-251, TMS: TO-251S, TMS2: TO-251S2, TN3: TO-252, TMS4: TO-251S4, TND: TO-252D, T2Q: TO-262, TQ2: TO-263, K08-5060: DFN5060-8 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING

PACKAGE		MARKING	
TO-220	TO-251S2		
TO-220F	TO-251S4		
TO-220F1	TO-251NS2		
TO-220F2	TO-252		
TO-220F3	TO-252D		
TO-251	TO-262		
TO-251S	TO-263		
DFN5060-8			

■ ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	V_{DSS}	650	V	
Gate-Source Voltage	V_{GSS}	± 30	V	
Avalanche Current (Note2)	I_{AR}	4.4	A	
Drain Current	Continuous I_D	4.0	A	
	Pulsed (Note2) I_{DM}	16	A	
Avalanche Energy	Single Pulsed (Note3) E_{AS}	200	mJ	
	Repetitive (Note2) E_{AR}	10.6	mJ	
Peak Diode Recovery dv/dt (Note4)	dv/dt	4.5	V/ns	
Power Dissipation	TO-220/TO-262/TO-263	P_D	106	W
	TO-220F/TO-220F1		35	W
	TO-220F3		36	W
	TO-220F2		50	W
	TO-251/ TO-251S		30	W
	TO-251S2/TO-251S4			
	TO-251NS2/TO-252			
Junction Temperature	TO-252D			
	DFN5060-8			
Junction Temperature	T_J	+150	°C	
Operating Temperature	T_{OPR}	-55 ~ +150	°C	
Storage Temperature	T_{STG}	-55 ~ +150	°C	

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 30mH, $I_{AS} = 3.65\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq 4.4\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	PACKAGE	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-262/TO-263	θ_{JA}	62.5	°C/W
	TO-220F/TO-220F1			
	TO-220F2/TO-220F3			
Junction to Case	TO-251/ TO-251S	θ_{JC}	110	°C/W
	TO-251S2/TO-251S4			
	TO-251NS2/TO-252			
	TO-252D			
	DFN5060-8		75	°C/W
	TO-220/TO-262/TO-263		1.18	°C/W
	TO-220F/TO-220F1		3.5	°C/W
	TO-220F3			
	TO-220F2		3.4	°C/W
	TO-251/ TO-251S		2.5	°C/W
	TO-251S2/TO-251S4			
	TO-251NS2/TO-252			
	TO-252D			
	DFN5060-8		4.17	°C/W

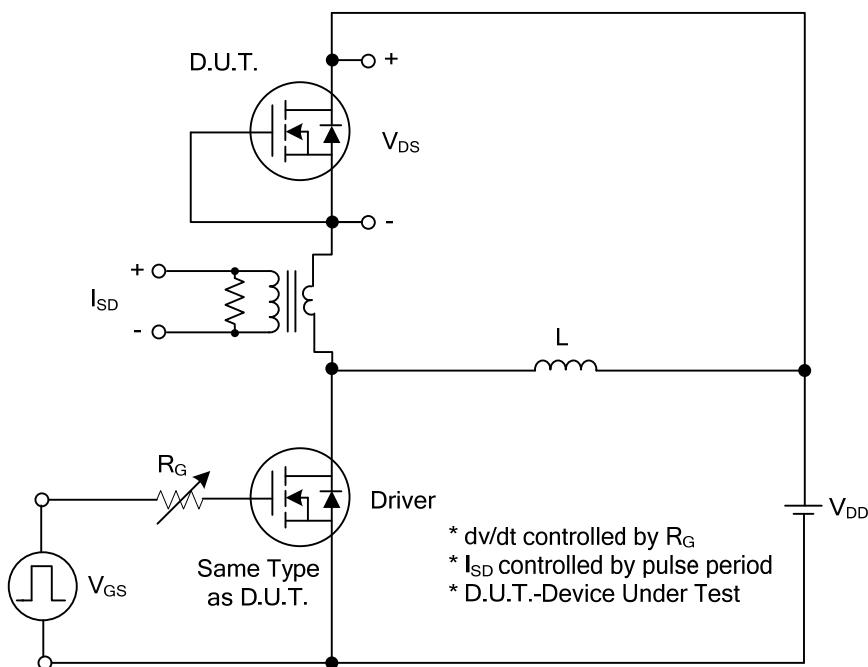
■ ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}} = 0 \text{ V}, \text{I}_D = 250\mu\text{A}$	650			V
Drain-Source Leakage Current	I_{DSS}	$\text{V}_{\text{DS}} = 650 \text{ V}, \text{V}_{\text{GS}} = 0 \text{ V}$		10		μA
Gate-Source Leakage Current	Forward	$\text{V}_{\text{GS}} = 30 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}$		100		nA
	Reverse	$\text{V}_{\text{GS}} = -30 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}$		-100		nA
Breakdown Voltage Temperature Coefficient	$\Delta\text{BV}_{\text{DSS}}/\Delta T_J$	$\text{I}_D = 250\mu\text{A}$, Referenced to 25°C	0.6			$\text{V}/^\circ\text{C}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$\text{V}_{\text{GS(TH)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$\text{R}_{\text{DS(ON)}}$	$\text{V}_{\text{GS}} = 10 \text{ V}, \text{I}_D = 2.2\text{A}$		2.3	2.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$\text{V}_{\text{DS}} = 25 \text{ V}, \text{V}_{\text{GS}} = 0\text{V},$ $f = 1\text{MHz}$		500	580	pF
Output Capacitance	C_{OSS}			90	110	pF
Reverse Transfer Capacitance	C_{RSS}			15	18	pF
SWITCHING CHARACTERISTICS						
Total Gate Charge	Q_G	$\text{V}_{\text{DS}} = 520\text{V}, \text{I}_D = 4.0\text{A},$ $\text{V}_{\text{GS}} = 10\text{V}$ (Note 1, 2)		70	90	nC
Gate-Source Charge	Q_{GS}			15	21	nC
Gate-Drain Charge	Q_{GD}			21	27	nC
Turn-On Delay Time	$t_{\text{D(ON)}}$	$\text{V}_{\text{DS}} = 325\text{V}, \text{I}_D = 4.0\text{A},$ $\text{R}_G = 25\Omega$ (Note 1, 2)		42	80	ns
Turn-On Rise Time	t_R			60	100	ns
Turn-Off Delay Time	$t_{\text{D(OFF)}}$			135	175	ns
Turn-Off Fall Time	t_F			70	110	ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S	$\text{V}_{\text{GS}} = 0 \text{ V}, \text{I}_S = 4.4\text{A}$			4.4	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				17.6	A
Drain-Source Diode Forward Voltage	V_{SD}				1.4	V
Reverse Recovery Time	t_{rr}	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_S = 4.4\text{A},$ $d\text{I}_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 1)		250		ns
Reverse Recovery Charge	Q_{rr}			1.5		μC

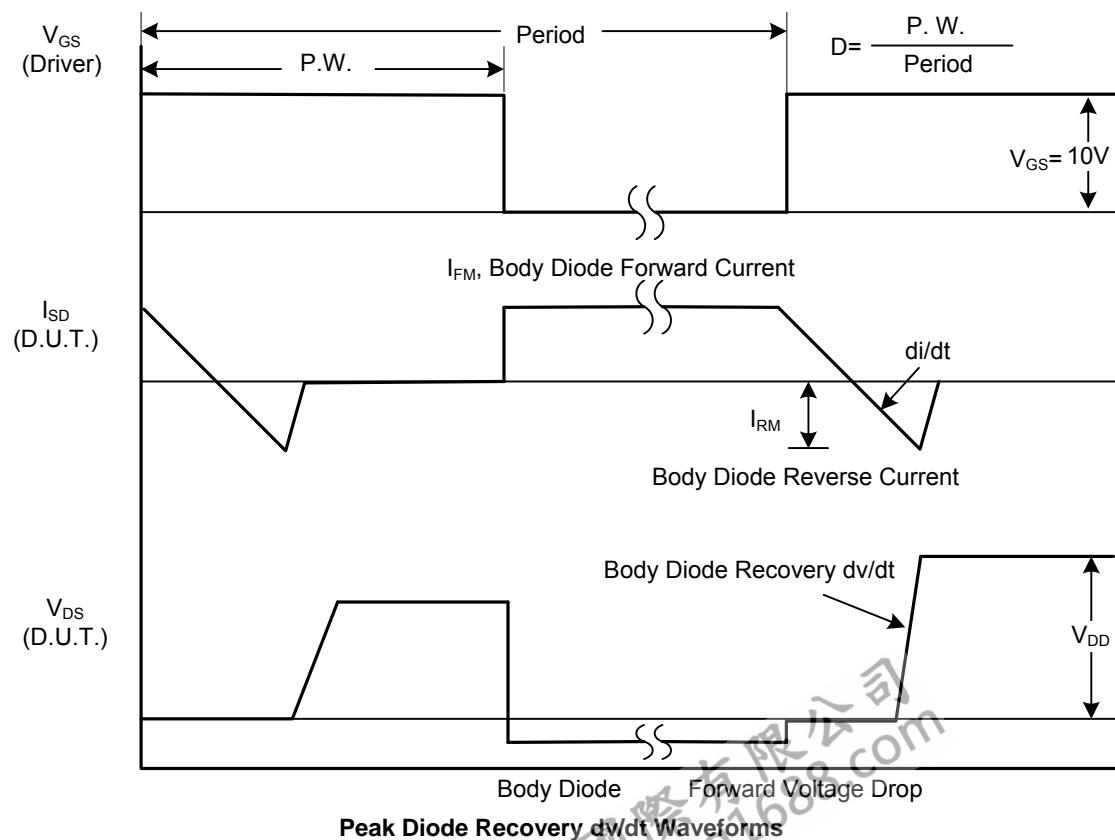
Note: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

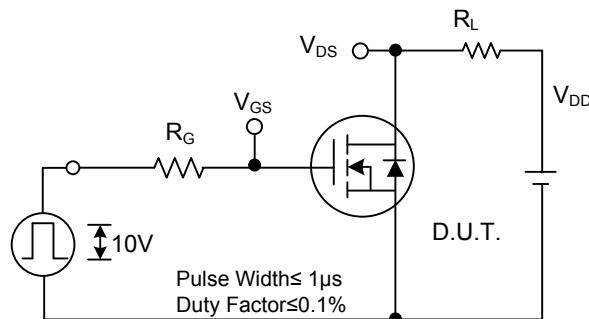
■ TEST CIRCUITS AND WAVEFORMS



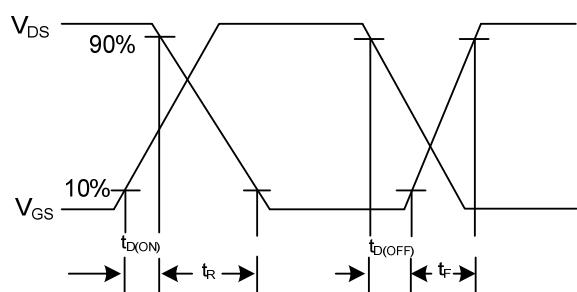
Peak Diode Recovery dv/dt Test Circuit



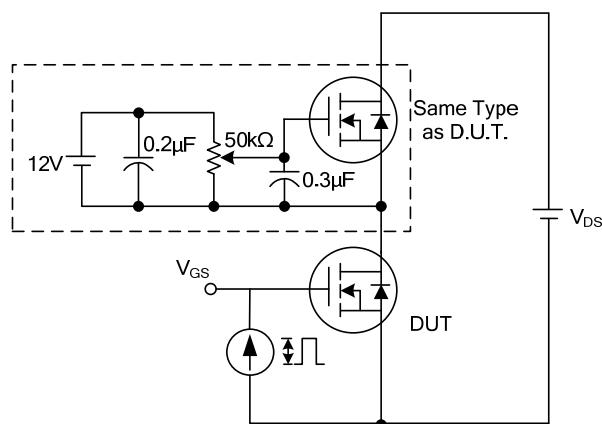
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



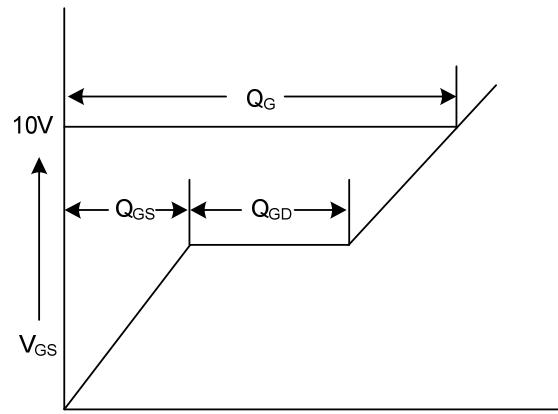
Switching Test Circuit



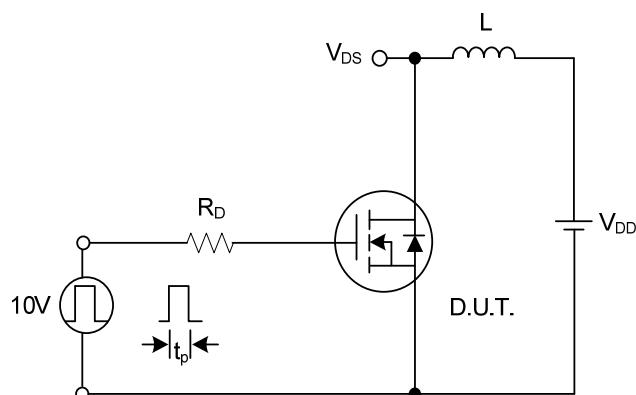
Switching Waveforms



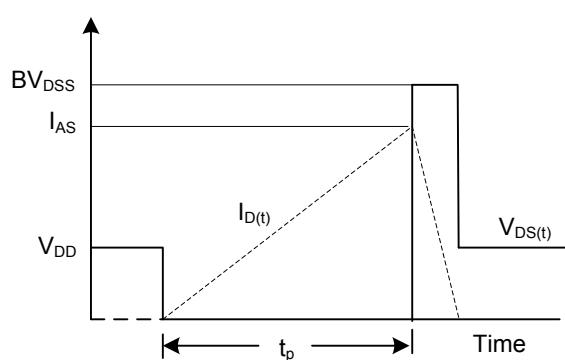
Gate Charge Test Circuit



Gate Charge Waveform

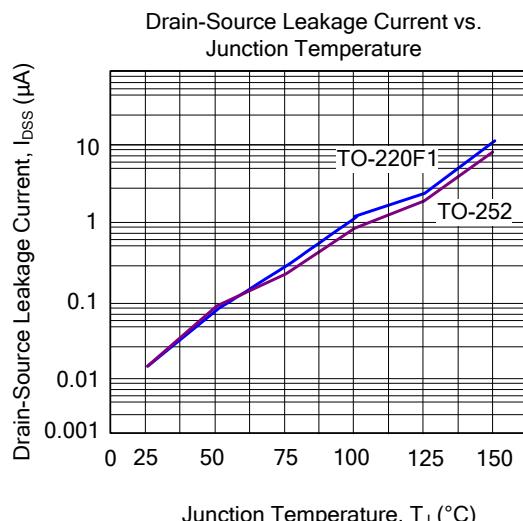
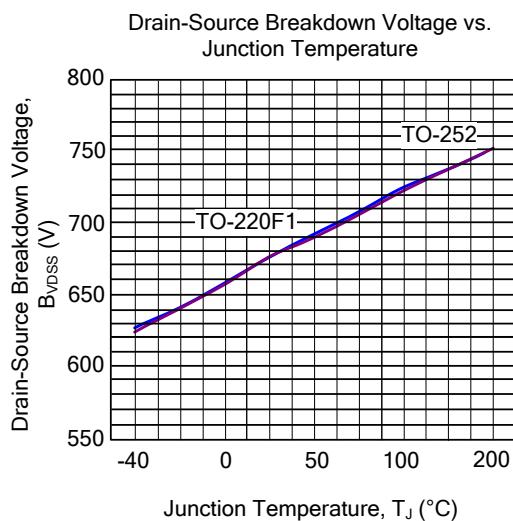


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

- TYPICAL CHARACTERISTICS



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